Applicant(s)/Patent Under Reexamination Application/Control No. 10/625,921 LUCAS ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 1723 Yoon-Young Kim **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,769,096	09-1988	Vander Giessen et al.	156/69
*	В	US-		·	
	С	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-		,	
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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